

Notice of References Cited	Application/Control No. 10/814,077	Applicant(s)/Patent Under Reexamination TAKANO ET AL.	
	Examiner Craig A. Renner	Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0212923 A1	10-2004	Taguchi, Tomoko	360/125
*	B	US-2005/0068671 A1	03-2005	Hsu et al.	360/125
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NON-PATENT DOCUMENTS

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